


<b>Search Notes</b> 	<b>Application/Control No.</b> 10527911	<b>Applicant(s)/Patent Under Reexamination</b> KNEE ET AL.
	<b>Examiner</b> EUENG-NAN YE	<b>Art Unit</b> 2624

SEARCHED			
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SEARCH NOTES		
Search Notes	Date	Examiner
(382/172) text search - see search outputs	2008/02/06	/ey/
(382/173,164,171) text search - see search outputs	2008/03/14	/ey/
EAST text search - see search outputs	2008/02/06	/ey/
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